

## **IEC QUALITY ASSESSMENT SYSTEM (IECQ)**

covering Electronic Components, Assemblies, Related Materials and Processes

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## Schedule of Scope to Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.: IECQ-L ULTW 20.0003
CB Certificate No.: 20005894 ITL

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## Appendix-1 (20005894 ITL) Schedule of Scope to Certificate of Approval

Test Items	Standard/Method
Pre-conditioning (PC)	AEC-Q101/Q102 \ JESD22-A113
High Temperature Reverse Bias (HTRB) /	AEC-Q101/Q102 \ MIL-STD-750-1
High Temperature Gate Bias (HTGB)	Method 1038 \ JESD22-A108
Temperature Cycling (TC)	AEC-Q101/Q102 \ JESD22-A104
Power Temperature Cycling (PTC)	AEC-Q101/Q102 \ JESD22-A105
High Humidity High Temperature Reverse Bias (H³TRB)	AEC-Q101/Q102 \ JESD22-A101
Intermittent Operational Life (IOL)	AEC-Q101/Q102 \ MIL-STD-750 Method 1037
Optical Measurement	CIE 127
ESD/HBM	ANSI/ESDA/JEDEC JS-001

Technical Reviewer of DQS: Date: 01/22/2024

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